

## 136A, 100V N-CHANNEL MOSFET

#### **DESCRIPTION**

SVGP104R1NL5 is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan's LVMOS technology. The improved process and cell structure have been especially tailored to minimize on-state resistance, provide superior switching performance.

This device is widely used in power management for UPS and Inverter Systems.

#### **FEATURES**

- 136A, 100V,  $R_{DS(on)(typ.)}$ =3.4m $\Omega@V_{GS}$ =10V
- Low gate charge
- Low Crss
- Fast switching
- Extreme dv/dt rated
- 100% avalanche tested
- Pb-free lead plating
- RoHS compliant

## KEY PERFORMANCE PARAMETERS

Characteristics	Ratings	Unit
V <sub>DS</sub>	100	V
$V_{GS(th)}$	2.3~3.9	V
R <sub>DS(on),max</sub> .	4.0	mΩ
I <sub>D</sub>	136	Α
Q <sub>g.typ.</sub>	63	nC

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## **ORDERING INFORMATION**

Part No.	Part No. Package		Hazardous Substance Control	Packing Type	
SVGP104R1NL5TR	PDFN-8-5X6X0.95-1.27	P104R1NL5	Halogen free	Tape&Reel	

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## ABSOLUTE MAXIMUM RATINGS (UNLESS OTHERWISE NOTED, TJ=25°C)

Characteristics	Cumbal	Symbol Test conditions		Unit			
Characteristics	Symbol	rest conditions	Min.	Тур.	Max.	Oilit	
Drain-source Voltage	$V_{DS}$		100			V	
Gate-source Voltage	$V_{GS}$		-20		20	V	
Drain Current (Note 1)		T <sub>C</sub> =25°C			136	Α	
Drain Current (Note 1)	Ι <sub>D</sub>	T <sub>C</sub> =100°C			86	Α	
Drain Current Pulsed (Note 2)	I <sub>DM</sub>	T <sub>C</sub> =25°C			544	Α	
Power Dissipation (Note 3)	$P_D$	T <sub>C</sub> =25°C			147	W	
Single Pulsed Avalanche	_	L=0.5mH, $V_{DD}$ =80V, $R_G$ =25 $\Omega$ ,			289	mJ	
Energy	E <sub>AS</sub>	starting temperature T <sub>J</sub> =25°C					
Single Pulsed Avalanche		_				34	Α
Current	I <sub>AS</sub>		-		34	A	
Operation Junction	т.	Тл	-55		150	°C	
Temperature Range	1 J		-33		130		
Storage Temperature Range	T <sub>stg</sub>		-55		150	°C	

### THERMAL CHARACTERISTICS

Characteristics	Symbol	Test conditions		Unit		
			Min.	Тур.	Max.	Onit
Thermal Resistance,	В				0.85	°C/W
Junction-case, Bottom	$R_{\theta JC}$				0.65	-0/00
Thermal Resistance,	$R_{ heta JA}$				50	°C/W
Junction-ambient						
Soldering Temperature	_	Reflow soldering: 10±1sec,3times	ı		260	°C
(SMD)	T <sub>sold</sub>					<u>.</u>

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## ELECTRICAL CHARACTERISTICS (UNLESS OTHERWISE NOTED, TJ=25°C)

#### Static characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
Characteristics		rest conditions	Min.	Тур.	Max.	Offic
Drain-source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	100			V
Drain-source Leakage Current	1	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	-	-	1.0	μА
	I <sub>DSS</sub>	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C	-	5.0	-	
Gate-source Leakage Current	I <sub>GSS</sub>	$V_{GS}=\pm20V$ , $V_{DS}=0V$	1	1	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_{D}=250\mu A$	2.3	1	3.9	<b>V</b>
Static Drain-source	D	V <sub>GS</sub> =10V, I <sub>D</sub> =50A		3.4	4.0	mΩ
On State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =6V, I <sub>D</sub> =25A		4.0	5.6	mΩ
Gate Resistance	$R_g$	f=1MHz		3.3		Ω

#### **Dynamic characteristics**

Ob a was about a time	Comple at	Symbol Test conditions	Ratings			1.1
Characteristics	Symbol		Min.	Тур.	Max.	Unit
Input Capacitance	C <sub>iss</sub>			4760		
Output Capacitance	Coss	f=1MHz, V <sub>GS</sub> =0V, V <sub>DS</sub> =50V		620		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			17		
Turn-on Delay Time	t <sub>d(on)</sub>	V 50V V 40V B 00		31		
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =50V, $V_{GS}$ =10V, $R_{G}$ =3 $\Omega$ ,		96		
Turn-off Delay Time	t <sub>d(off)</sub>	I <sub>D</sub> =50A (Notes 4.5)		60		ns
Turn-off Fall Time	t <sub>f</sub>	(Notes 4, 5)		25		
Total Gate Charge	Qg			63		
Gate-source Charge	$Q_{gs}$	V <sub>DD</sub> =50V, V <sub>GS</sub> =10V, I <sub>D</sub> =50A		30		nC
Gate-drain Charge	$Q_{gd}$	(Notes 4, 5)		9.0		
Gate-plateau Voltage	V <sub>plateau</sub>			5.9		V

#### Reverse diode characteristics

Characteristics	Symbol	Test conditions	Ratings			Unit
Onaracteristics	Symbol	rest conditions	Min.	Тур.	Max.	o iii
Continuous Diode Forward Current	Is	Integral reverse P-N junction	-		136	Α
Diode Pulse Current	I <sub>S,pulse</sub>	diode in the MOSFET	1		544	ζ.
Diode Forward Voltage	$V_{SD}$	I <sub>S</sub> =50A, V <sub>GS</sub> =0V			1.4	V
Reverse Recovery Time	T <sub>rr</sub>	I <sub>S</sub> =50A, V <sub>GS</sub> =0V, V <sub>R</sub> =50V		60		ns
Reverse Recovery Charge	$Q_{rr}$	dI <sub>F</sub> /dt=100A/μs (Note 4)		99		nC

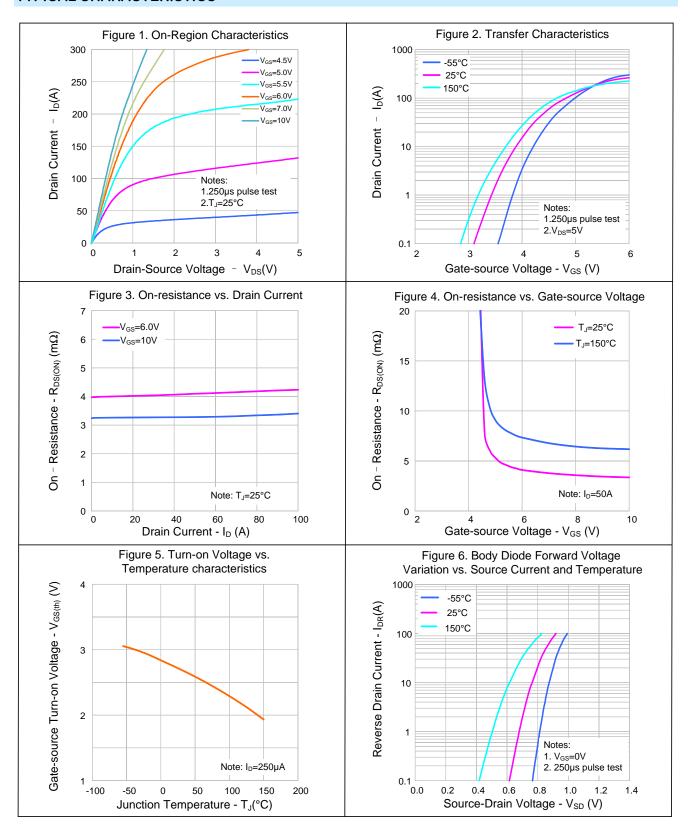
#### Notes:

- 1. The rated value only refers to the maximum absolute value at the case temperature of 25°C in the specification. If the case temperature is higher than 25°C, it should be derated according to the actual environmental conditions;
- 2. Pulse time 5µs, pulse width is limited by the maximum junction temperature;
- 3. The dissipation power will change with temperature, derating above 25°C: 1.18W/°C;
- 4. Pulse Test: Pulse width ≤300µs, Duty cycle≤2%;
- 5. Essentially independent of operating temperature.

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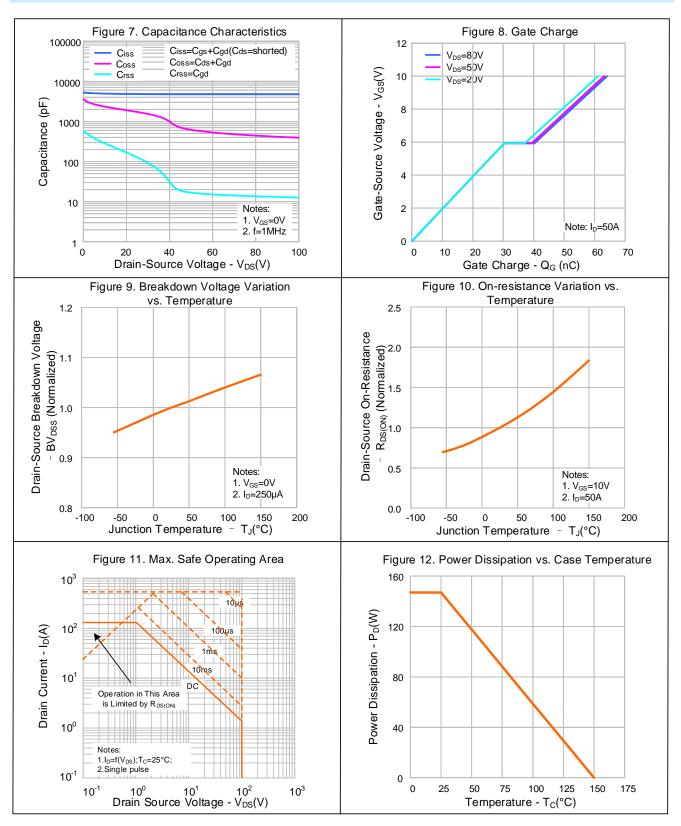
#### TYPICAL CHARACTERISTICS



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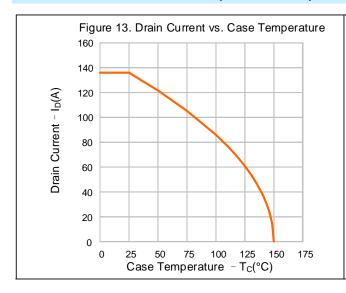
### TYPICAL CHARACTERISTICS (CONTINUED)

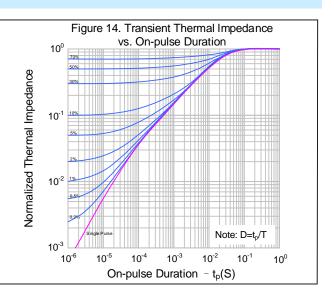


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## **TYPICAL CHARACTERISTICS (CONTINUED)**



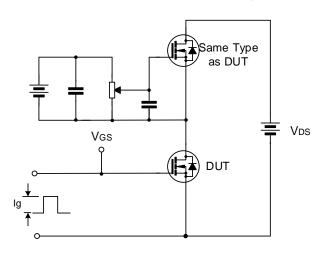


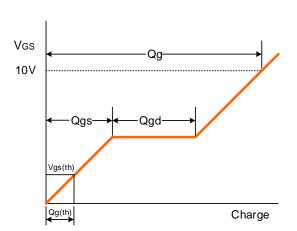
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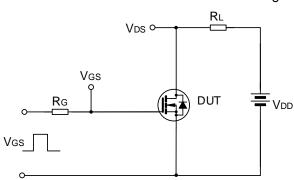
### **TYPICAL TEST CIRCUIT**

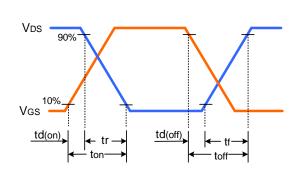
## Gate Charge Test Circuit & Waveform



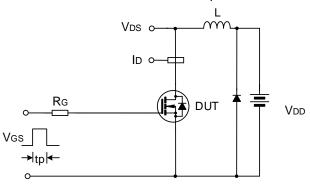


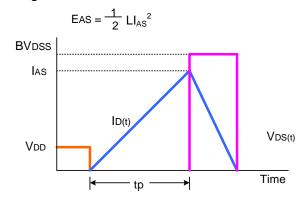
### Resistive Switching Test Circuit & Waveform





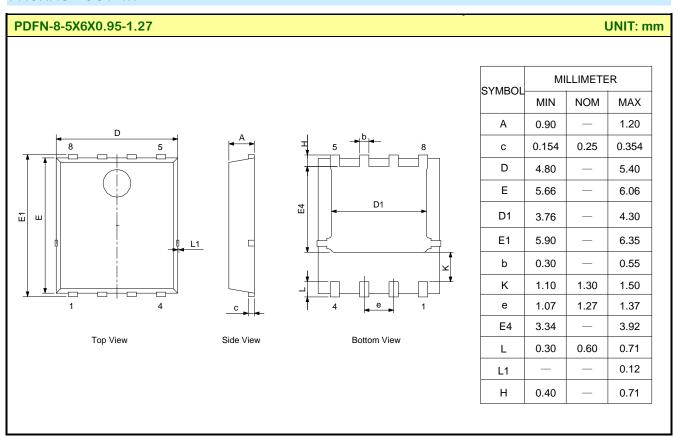
## Unclamped Inductive Switching Test Circuit & Waveform







#### **PACKAGE OUTLINE**





#### **MOS DEVICES OPERATE NOTES:**

Electrostatic charges may exist in many things. Please take following preventive measures to prevent effectively the MOS electric circuit as a result of the damage which is caused by discharge:

- The operator must put on wrist strap which should be earthed to against electrostatic.
- Equipment cases should be earthed.
- All tools used during assembly, including soldering tools and solder baths, must be earthed.
- MOS devices should be packed in antistatic/conductive containers for transportation.

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Rev.: 1.3

Revision History:

1. Delete the wave soldering condition

2. Update the typical test circuit

3. Update the important notice

Rev.: 1.2

Revision History:

1. Update I<sub>D</sub> and SOA

2. Add figure 13 and figure 14

Rev.: 1.

Revision History:

1. Update electrical characteristics

2. Update figure 7 and figure 8

Rev.: 1.0

Revision History:

1. First release

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